

FORM PTO-1449
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. HELDMANN ET AL

SERIAL NO.

10/185, 627

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT Consortium für elektrochemische Industrie GmbH

Heldmann et al.

FILING DATE:

Feb. 24, 2004

GROUP:

1626

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
JMN	AA	US 2003/0088105	5/8/2003	Krich et al.	548	201	10-15-2002
	AB						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
JMN	AL	WO 01/72702	10/4/2001	PCT				
	AM							
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)


JMN	AR	Seebach et al., Helvetica Chimica Acta, 1987, vol. 70, no. 4, pages 1194-1216
JMN	AS	Moloney et al., Tetrahedron: Asymmetry, Elsevier Science Ltd., 1994, vol. 5, no. 8, pages 1477-1478
JMN	AT	Moloney et al., Journal of the Chemical Society, Perkin Transactions I, 1996, pages 227-228

EXAMINER

DATE CONSIDERED

11-22-05

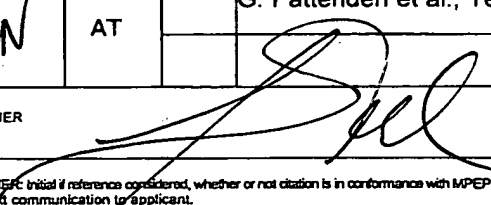
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FORM PTO-1449 (REV. 7-80)				ATTY. DOCKET NO: Co 10221		SERIAL NO. 10/785,627	
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: HELDMANN ET AL.			
				FILING DATE: 02/24/04		GROUP: 1626	

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							YES	NO
JMN	AL	WO 01/72702	10/4/2001	PCT				
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JMN	AR		Seebach et al., Tetrahedron Letters, 1984, vol. 25, no. 24, pages 2545-2548
JMN	AS		Seebach et al., Helvetica Chimica Acta, 1987, vol. 70, pages 1194-1216
JMN	AT		G. Pattenden et al., Tetrahedron Letters, 1993, vol. 49, no. 10, pages 2131-2138

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JMN	AR	G. Mulqueen et al., Tetrahedron, 1993, vol. 49, no. 24, pages 5359-5364					
JMN	AS	Seebach et al., Angew. Chem. 1988, 100, pages 1685-1715					
JMN	AT	Protecting Groups, P.J. Kocienski, Thieme Verlag, 1994, pages 185-243					
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JMN	AR		Protecting Groups, P.J. Kocienski, Thieme Verlag, 1994, pages 118-154
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